

<b>Notice of References Cited</b>	Application/Control No. 10/531,430		Applicant(s)/Patent Under Reexamination JEAL ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,761,309	06-1998	Ohashi et al.	713/156
*	B	US-2002/0134837 A1	09-2002	Kishon, Jakob	235/449
*	C	US-2005/0177515 A1	08-2005	Kalavade et al.	705/052
*	D	US-7,296,098 B2	11-2007	Shih, Hsuan-Ming	710/13
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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